

Search Notes

Application/Control No.

10/708,836

Examiner

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Applicant(s)/Patent under
Reexamination

BEENAU ET AL.

Art Unit

2635

SEARCHED

Class	Subclass	Date	Examiner
340	5.53	11/29/2005	NN
340	5.2	11/29/2005	NN
340	5.4+	11/29/2005	NN
340	5.52	11/29/2005	NN
340	5.6	11/29/2005	NN
340	5.8+	11/29/2005	NN
340	10.1	11/29/2005	NN
340	10.4-10.5	11/29/2005	NN
235	379	11/29/2005	NN
235	380	11/29/2005	NN
235	492	11/29/2005	NN
705	35,54,76	11/29/2005	NN
705	186,194	11/29/2005	NN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search: USPAT; US-PUB; EPO; JPO; and Derwent.	11/29/2005	NN